Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/684,188	FUJII ET AL.
Examiner	Art Unit

3616

Drew J. Brown

	SEAR	CHED	
Class	Subclass	Date	Examiner
280	728.3	8/18/2005	DB
280	732	8/18/2005	DB
Updated		6/2/2006	DB
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INT	ERFERENC	FERENCE SEARCHED		
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
David Dunn	8/18/2005	DB	